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Temperature Dependence of Charge Localization in High-Mobility, Solution-Crystallized Small Molecule Semiconductors Studied by Charge Modulation Spectroscopy

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In solution-processable small molecule semiconductors, the extent of charge carrier wavefunction localization induced by dynamic disorder can be probed spectroscopically as a function of temperature using charge modulation spectroscopy (CMS). Here, it is shown based on combined field-effect transistor and CMS measurements as a function of temperature that in certain molecular semiconductors, such as solution-processible pentacene, charge carriers become trapped at low temperatures in environments in which the charges become highly localized on individual molecules, while in some other molecules the charge carrier wavefunction can retain a degree of delocalization similar to what is present at room temperature. The experimental approach sheds new insight into the nature of shallow charge traps in these materials and allows identifying molecular systems in which intrinsic transport properties could, in principle, be observed at low temperatures if other transport bottlenecks associated with grain boundaries or contacts could be removed.

1. Introduction

Much has been learnt on the structure–activity relationship between molecular structure, solid-state ordering, and charge carrier mobility in high-mobility, molecular semiconductors over the last few decades and a variety of transport models have been proposed.^[1–3] The dynamic disorder model provides a solid framework for understanding the temperature-dependent charge carrier and transport properties on a molecular level. It assumes that even in the crystal phase, the extreme sensitivity of neighboring molecular orbitals to small nuclear displacements as a result of thermal fluctuations produces variations

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in the transfer integrals large enough to dynamically localize charge carriers.^[4-6] The model is able to explain the puzzling dichotomy associated with the observation of both band-like transport characteristics, such as a free-electron Hall effect, and signatures of carrier localization, such as a pronounced molecular charge-induced absorption in charge modulation spectroscopy (CMS) in several, high mobility molecular semiconductors.^[7,8] Supported by theoretical calculations and dynamic molecular simulations, Chang et al. highlighted the role of crystal packing as they demonstrated that 2D-6,13-bistriisopropylsilylethynyl pentacene (TIPS-P) is significantly more affected by dynamic disorder than is 1,4,8,11-tetramethyl-6,13-triethyl-

silylethynyl pentacene (TMTES-P). In

TIPS-P charge carriers at the Fermi level are expected to be less delocalized than in TMTES-P, which explains the nonideal Hall response and generally lower mobilities observed for TIPS-P.

Unfortunately, it has not been possible to date to study experimentally the intrinsic temperature dependence of transport in a dynamic disorder dominated system. Although in some systems a band-like temperature dependence, i.e., mobility decreasing with increasing temperature, has been observed in a temperature range between 200 and 300 K,^[9–12] at lower temperature the mobility is typically exhibiting a temperature-activated behavior. This is generally interpreted as a manifestation of shallow trap states, but the nature of these trap states is not understood in

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Figure 1. Chemical structure of the semiconducting small molecules compared in this study: a) TIPS-P, b) TMTES-P, c) β -TMTIPS-P, and d) diF-TES-ADT.

most systems. They could be due to structural point defects or chemical impurities present in the bulk of crystalline grains, states associated with grain boundaries^[13] or states localized at the semiconductor-dielectric interface.[14-16] Identification of their origin is challenging as few spectroscopic probes exist that are able to detect interfacial trapped charge species at concentrations typically less than 10¹² per cm². CMS provides a powerful spectroscopic technique to study the nature of such shallow trap states. As long as the shallow trap states can be filled and emptied on the time scale of the modulation of the charge carrier concentration in the accumulation layer of a field-effect transistor (FET) by an applied gate voltage, CMS provides spectroscopic information about the nature of the associated charge carriers as a function of temperature which can be directly correlated with the measured temperature dependence of the field-effect mobility. For example, in TIPS-P Sakanoue et al.[11] observed a sharpening of the charge-induced absorption CMS signature at low temperature, in the same temperature regime in which the mobility became thermally activated. This was interpreted in terms of a shallow trap state in which the charge carrier wavefunction becomes localized onto a single TIPS-P molecule. As a direct fingerprint of the degree of localization sensed by mobile charges in the FET accumulation layer the CMS spectra at low temperature as compared to the room temperature spectra may contain key information about the trapping mechanisms in particular materials systems.

Here we present the results of a CMS/temperature-dependent mobility study comparing TIPS-P and TMTES-P to other highmobility solution-processable acenes, including another soluble pentacene derivative, 2,3,9,10-tetramethyl-6,13-triisopropylsilylethynyl-pentacene (β -TMTIPS-P) and 2,8-difluoro-5,11-triethylsilylethynyl-anthradithiophene (diF-TES-ADT) (Figure 1), that is one of the most widely studied, highest mobility, solution processable heteroatom acene derivatives. In single crystals the former packs into strongly interacting, cofacial 1D structures (Figure S1, Supporting Information), whilst the latter is known for its 2D-brickwall packing.^[17] We observe significant differences between these molecules in the degree of charge carrier wavefunction localization in the trap-dominated regime at low temperature that leads us to conclude that the nature of shallow traps in these systems is not universal but may be different from system to system.

2. Results

We first measured, for each compound, the temperature dependence of the mobility in the top-gate, bottom-contact FET architecture. We grew polycrystalline (single component) thin films by spin-coating on top of pentafluorobenzenethioltreated Au source-drain electrodes and selected Cytop, a perfluorinated, low k-polymer as the gate dielectric to reduce charge trapping at the gate insulator/semiconductor interface. All molecules gave good p-channel FET characteristics in 20 um channel devices, with room-temperature mobilities of 0.7 cm² V⁻¹ s⁻¹ (β-TMTIPS-P), 1.2 cm² V⁻¹ s⁻¹ (TIPS-P), 1.9 cm² V⁻¹ s⁻¹ (TMTES-P), and 2.5 cm² V⁻¹ s⁻¹ (diF-TES-ADT). At relatively high drain voltage, $V_{\rm D} = -40$ V, in TIPS-P we found the absolute current and the slope of the saturated transfer characteristics, i.e., the extracted effective mobility, to increase monotonically with decreasing temperature in the temperature range 240 K < T < 300 K, before dropping upon further cooling, in line with previous reports^[11] In fact, we measured a negative temperature coefficient of the mobility for all four compounds, even for β -TMTIPS-P (Figure 2a) with its room-temperature mobility well below the Mott-Ioffe-Regel limit, which requires the mobility μ to be larger than $\mu > e a^2 W/(\hbar k_B T)$ for a bandtransport description to be valid. Here a is the lattice constant and W is the estimated bandwidth (assumed to be typically on the order of 100 meV). Regardless of their starting (room temperature) performance, all molecules were found to share a similar electrical behavior at low temperature too, as past a pivotal temperature all mobilities become thermally assisted, i.e., the transport becomes trap limited. The differences lie in the value of the cross-over temperatures (associated with trap density) and in the activation energies E_a extracted from an exponential fit of the mobility in the trap-limited low-temperature transport regime. In TIPS-P we calculated characteristic activation energies >25 meV; that is equivalent to a trap depth around five times deeper than that in β -TMTIPS-P ($E_a \approx 6$ meV). TMTES-P was found to sit in the middle of TIPS-P and β -TMTIPS-P, with $E_a \approx 13$ meV. In diF-TES-ADT a more complex temperature dependence of the mobility was observed with a narrow temperature range between 150 and 200 K, where a relatively high activation energy of ≈37 meV could be extracted and a regime below 150 K with a smaller activation energy of ≈15 meV. We measured three samples prepared under identical conditions and observed only small variations in the value of these activation energies (<5 meV).

In light of these subtle differences we then measured the CMS spectra of all molecules as a function of temperature, following the methodology described in ref. [11]. Typically, a negative DC bias was applied to a semitransparent FET fabricated in a top-gate configuration, optimized to remove any artifacts in the measurement. This allowed probing of positively charged carriers in the semiconductor that are attracted to the



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Figure 2. a) Temperature-dependent saturation mobility ($V_D = -40$ V) measured in 20 µm channel (from top to bottom) TIPS-P, TMTES-P, β -TMTIPS-P, and diF-TES-ADT FETs, with top-gate architecture and ≈ 470 nm thick Cytop dielectric. The activation energies (E_a) extracted in the trap-dominated regimes (dashed lines) are also given. b) Temperature-dependent differential transmission CMS spectrum of (from top to bottom) TIPS-P, TMTES-P, β -TMTIPS-P, and diF-TES-ADT transistors. The light blue curves are the respective thin-film absorption spectra. TIPS-P and TMTES-P spectra were extracted with permission from Ref. [11].

interface with the dielectric. If charge injection is accompanied by structural reorganization of the molecules and the formation of polaronic levels within the semiconductor gap, new optical transitions below the π - π * absorption can be detected as a weak modulation of the transmission spectrum. In all molecules studied here we observe at broad, subgap chargeinduced absorption between 1.1 and 2 eV, that is also observed in rubrene single crystals studied in ref. [11]. This is evidence of the molecular reorganization associated with the localized nature of the charge carriers in these materials leading to



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characteristic charge-induced absorption different from that of the neutral molecule. The spectra for TIPS-P were obtained from a material batch from a different supplier than that used in Sakanoue's work and were found to be very similar to those shown in ref. ^[11] exhibiting a broad charge-induced absorption with $\Delta T/T < 0$ between 1.1 and 2 eV that sharpens into a band centered ≈ 1.25 eV at low temperatures (Figures 2b and 4a), the shape of which is very similar to that of the isolated radical cation in solution (Figure S2, Supporting Information). This suggests that the observed localization of charges that is evident in the sharpening of the polaron absorption band is not related to specific, supplier-dependent chemical impurities.

We established the room temperature spectrum of β -TMTIPS-P (Figure 2b) to be qualitatively similar to that of TIPS-P and TMTES-P. We detected a broad, low-energy chargeinduced absorption \approx 1.2–1.5 eV, and a higher-lying transition at 2.5–2.6 eV which resemble those found in TIPS-P, only slightly redshifted. Taking into account errors in estimating transition energies in the gas phase, these are reasonably well predicted by quantum-chemical calculations performed on singly charged, isolated β -TMTIPS-P molecules and dimers (Figure 3). Such calculations were also performed for the other molecules, for which similar results were obtained. The position of the cation-induced absorptions ≈1.5 and 3.5 eV in the simulated spectra is different between the monomer and the dimer, which demonstrates that the peak position varies depending on the degree of charge delocalization. In fact, our interpretation of the broad cation-induced absorption observed at room temperature within the dynamic disorder framework is that the spectra are broadened by statistical averaging over molecular configurations in which the charge is delocalized over a different number of molecules as a result of thermal lattice fluctuations.^[8] The optical absorption of a photon is an ultrafast process occurring on a timescale on which the thermal lattice fluctuations responsible for dynamic disorder are effectively frozen and the ensemble of charge carriers present in the accumulation layer of the FET is expected to comprise a statistical distribution of configurations with different degrees of charge delocalization, each of which absorbs at a different wavelength. The difference between β -TMTIPS-P and TIPS-P at 300 K is that in the former we detected a significantly smaller, net $\Delta T/T > 0$ signal for the bleaching of the neutral highest occupied molecular orbital-lowest unoccupied molecular orbital (HOMO-LUMO) transition ≈1.7-2.0 eV, but a considerably stronger signal for the higher-lying bleaching signal \approx 2.7 eV. The vibronic transitions, which are clearly visible at 1.71, 1.87, and 1.98 eV, together with the bleaching at 2.7 eV are in excellent agreement with those detected in the thin film absorption spectrum (in light blue in Figure 2b). The absence of net bleaching signal was previously observed in TMTES-P and was explained by a background signal from a Drude-like optical conductivity in this region;^[11] however, here the neutral π - π * absorption is already much weaker in the β -TMTIPS-P thin film than for the other compounds.

While β -TMTIPS-P shares common characteristic features with TIPS-P and TMTES-P at room temperature, we observed a very different dependence of its CMS spectrum on temperature than that found in TIPS-P and TMTES-P. Remarkably, the broad charge-induced absorption at room temperature does not sharpen or intensify dramatically with decreasing temperature. of the isolated radical cation in solution (which is the same as TIPS-P, only redshifted). This implies that in β -TMTIPS-P the temperature activation of the mobility at low temperatures cannot be attributed to the same type of shallow trap that leads to localization of the charges onto single molecules in TIPS-P. It is interesting to note that out of the three pentacene derivatives, it is in β -TMTIPS-P that we calculated the lowest activation energy (Figure 2a). In contrast, in TIPS-P, which shows the strongest CMS temperature dependence with completely localized charges at low temperatures, we measured the largest activation energy. At an intermediate value of E_2 between that of TIPS-P and β -TMTIPS-P, TMTES-P exhibits an intermediate degree of charge localization/peak sharpening. From the comparison of these three molecules there appears to be a trend for molecules in which the charges become strongly localized at low temperature due to presence of traps to exhibit particularly large activation energies for transport. However, it is important to note that there does not appear to be a correlation with the magnitude of the mobility; although β -TMTIPS-P exhibits no evidence for charge localization at low temperatures, the mobility is the lowest among the three materials. This is likely to reflect other factors that govern the mobility but are unlikely to influence the CMS spectra, such as potential barriers associated with contact or grain boundaries.

The apparent correlation between the magnitude of the activation energy and charge localization also does not extend to diF-TES-ADT. As shown in Figure 2b, its CMS spectrum is clearly temperature independent (this is true down to 20 K, not shown here) and behaves qualitatively like that of β -TMTIPS-P. The temperature dependence of the mobility of diF-TES-ADT does not follow a simple Arrhenius temperature-activated behavior below 200 K, but the temperature dependence in this regime is clearly stronger than in β -TMTIPS-P. Approximate



Figure 3. β -TMTIPS-P monomer and dimer's neutral and charged theoretical spectra obtained by quantum-chemical simulations performed at the semiempirical AM1 level with full configuration interaction, as implemented in the AMPAC 9.1 package. The structure selected for the dimer, which is the intermolecular configuration of two adjacent β -TMTIPS-P molecules stacked along the *a*-axis, is shown in the inset. For the charged dimer, the calculations predict the charge to be fully delocalized over the two molecules.



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activation energies of 15 and 37 meV can be extracted in the narrow temperature regimes from 100–150 and 150–200 K, respectively (Figure 2a). This may point to a different mechanism for charge trapping in diF-TES-ADT as discussed below. We note again that the bleaching signal at 2.26 eV is in excellent agreement with the neutral π – π * absorption in the thin film spectrum.

We now turn to a more detailed investigation of the origin of the shallow traps in TIPS-P, which cause charge carriers to sense a fully localized environment at low temperature. From the comparison with the other materials we have seen that such pronounced localization is not a common feature of high-mobility molecular semiconductors. In an attempt to gain insight into why TIPS-P is different, we measured the temperature-dependent CMS spectra of three TIPS-P devices from the same batch of material but with different thin film morphology and device performance: a highmobility sample (1.4 cm² V⁻¹ s⁻¹) exhibiting a neat spherulitic microstructure, an intermediate-mobility sample (0.8 cm² V⁻¹ s⁻¹) with a needle-like thin film structure, and a low-mobility sample (0.3 $\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$) which displays a much thicker and coarser needle microstructure, and overall more randomly oriented crystals (note that these surface morphologies were not achieved as part of a controlled process but are rather a product of the randomness associated with environmental (glovebox) conditions on the day of fabrication, see Figure 4).

Interestingly, in the low-mobility films showing a needle-like microstructure we observed for the first time a charge-induced absorption \approx 1.2–1.3 eV that was already somewhat sharp at room temperature (Figure 4). In the intermediate-mobility sample, the radical cation peak at 1.2–1.3 eV sharpens upon cooling too such that at 200 K it very clearly resembles that of the cation in solution, whilst one could see this in the spherulitic sample only at very low temperatures. At room temperature the peak at 1.2–1.3 eV is most pronounced in the low-mobility sample; it is somewhat broadened compared to that in the low temperature spectrum in the high

mobility sample, presumably as a result of thermal broadening. This suggests that the density of the shallow traps that is responsible for the localization of the carriers at low temperature in our high-mobility TIPS-P sample has increased significantly in the needle-like samples and already manifests itself in the nature of charges at room temperature. It is plausible that such poorly connected surface microstructures create bottlenecks to charge carrier transport and are directly responsible for the sharp decrease in FET mobility. But could grain-boundaries



Figure 4. Device optical images (left) and associated charge modulation spectra (right) of three TIPS-P samples: a) a high-mobility, spherulitic sample ($\mu = 1.4 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$), b) an intermediate-mobility sample ($\mu = 0.8 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$), and c) a low-mobility sample ($\mu = 0.3 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$) with a coarse needle-like microstructure, given at relevant temperatures. The red, dotted line in the spectrum of sample (c) shows the signal measured with the sample oriented 30° to the normal of the incident light, at 300 K. The differences between the two spectra suggest that there are some interference effects present particularly at higher photon energies.

alone, such as microsize gaps between crystals or twin boundaries, be the origin of the shallow trap states in TIPS-P observed in CMS? Because CMS measures an average spectrum over all charge carriers in the channel, the low temperature spectrum would imply that all charge carriers would then have to be located in grain boundaries at low temperatures. Furthermore grain boundaries exist in high density in other films such as those we produced with diF-TES-ADT^[18] yet do not lead to temperature-dependent CMS in the subgap region.



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The differences between the two spectra shown in Figure 4c measured with the sample oriented 30° to the normal of the incident light show that there are some interference effects present, which prevent us from interpreting the subtle features in the spectra particularly at higher photon energies. However, in the region \approx 1.2 eV these are relatively minor demonstrating that the peak at 1.2 eV observed already at room temperature in the low mobility sample does not stem from interference artefact. In addition, we emphasize that any differences in the spectra observed with temperature, such as the sharpening of the peak ≈1.2 eV with decreasing temperature observed in the other two samples, are unlikely to be caused by interference effects because the changes in the optical thickness of the active device stack that occur with temperature due to thermal contraction/expansion are expected to be negligibly small compared to the large changes in effective optical thickness that are involved when changing the angle of incidence from normal incidence to 30° incidence.

The observed behavior can be consistently explained as follows. In TIPS-P there are clearly specific traps states, most likely within the grains that are able to localize the charge carriers onto individual molecules at low temperatures. In contrast in diF-TES-ADT the charge carriers may be confined to individual grains at low temperature by potential barriers associated with grain boundaries but are not trapped on the molecular scale. The similarity of the low-temperature and room-temperature CMS spectra implies that charge carriers in diF-TES-ADT remain mobile within the grains even at low temperature. The activation energy of the mobility in diF-TES-ADT can then be considered to reflect the grain boundary potential. This interpretation is consistent with previous studies on these materials. Evidence for the absence of long-lived traps within the grains of spin-casted diF-TES-ADT transistors was previously reported by Marohn and co-workers.^[19] In their time-resolved electric force microscopy study, the authors also found evidence for intragrain trap states in TIPS-P solution-processed thin films, which supports our hypothesis. At this stage it is necessary to comment on the difference in charge traps observed by the two techniques. The electric force miscrosopc (EFM) experiment observed deep trap states that capture charges over timescales longer than seconds, whereas in CMS we observe shallow trap states in which charge carriers are still able to respond to gate voltage modulations on the time scale of 10 ms. It is possible that the states probed in TIPS-P CMS measurements are precursor states to deep charge traps in which a charge carrier circulates around a defect for some time, before it is fully captured in a deep trap state.

At present we cannot identify the nature of the defect within the grains of TIPS-P that causes the morphology dependent localization of carriers at low temperatures. The defects may well be a chemical impurity that is present in higher density in our needle films than in our spherulitic sample, to levels such that their presence is sensed by charge carriers already at room temperature. Our needle morphology samples were fabricated during a period of increased oxygen concentration in the laboratory glovebox. The low-mobility sample was fabricated first, then the intermediatemobility sample and finally the high-mobility sample, as the oxygen content fell down to its normal level. This is consistent with an impurity from oxidation or photochemical degradation rather than from synthesis. Oxygen in combination with light results in oxygen radicals that react with organic semiconductors and it is known that TIPS-P is prone to endoperoxide formation^[20] DiF-TES-ADT has been found to be more stable against photooxidation than pentacene based materials, which could explain why we see no such trap in the grains of diF-TES-ADT. The mechanism by which oxidation of TIPS-P influences crystallization kinetics and film morphology is not understood, but we note that similar observations on the correlation between chemical impurities and film morphology have been made in other systems. Needle-like surface structures formed by impurities segregating to the top of C8-BTBT films during spin coating were reported recently.^[21] We attempted to detect differences in the crystal packing/polymorphs present in the different films using grazing-incidence X-ray diffraction (GI-XRD), (Figure 5). The films show broadly similar diffraction patterns, which when compared with the model advanced by Anthony et al.^[22] indicate that the a-b plane of the unit cell is parallel to the substrate, i.e., the TIPS-pentacene molecules have their long edge oriented edge-on to the substrate.^[23] However, there are some clear differences in the diffraction patterns of the three films. The intermediate mobility sample with needle-like morphology has diffraction spots missing, which may be attributed to the long-range molecular alignment present in these films, which means that they cannot be considered as isotropic in the plane of the film. There are also more subtle differences in the position of diffractions spots of the high and low mobility samples, which might indicate that the films might comprise subtly different polymorphic structure^[24] A detailed microstructural analysis of the different films goes beyond the scope of our spectroscopy focused study. However, from the GI-XRD we cannot exclude the possibility that the different trapping behavior of the TIPS-P films could not be due to a chemical defect, but a structural defect in the bulk or at the active interface. To identify unambiguously the nature of these traps is challenging and will require the application of highly sensitive, analytical techniques.^[25]

3. Conclusion

Our study demonstrates that CMS is a powerful tool to study the correlation between the spectroscopic signature of charge traps and their effect on the temperature dependent charge transport properties as a function of molecular structure. We have observed clear spectroscopic evidence that in certain acene-based polycrystalline films the shallow charge traps within the grains, that localize charges onto single molecules at low temperatures in materials such as TIPS-P and TMTES-P, can be prevented. In systems, such as diF-TES-ADT and β -TMTIPS-P, the spectroscopic properties of charge carriers at low temperatures are very similar to those at room temperature suggesting that the charges remain mobile at low temperature within individual domains/grains. We cannot yet observe clean intrinsic transport properties in FET measurements at low temperature, possibly as a result of charge transport bottlenecks associated with grain boundaries or contact resistance. To remove these will require further optimization of film/ device processing or application of techniques that probe transport on a shorter length scale. However, CMS provides us with a powerful technique for identifying clean molecular systems in which intrinsic transport properties could, in principle, be observed at low temperatures.

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Figure 5. Grazing incidence X-ray diffraction on the various samples: a) high mobility spherulitic sample, b) intermediate mobility needle-like morphology, and c) low mobility coarse needle-like morphology. All the samples exhibit a high crystallinity and are highly oriented out-of-plane. While the samples in (a) and (c) have in-plane isotropy, the sample in (b) has considerable in-plane orientation, as evidenced by the imperfect mirror symmetry with many missing reflections. The approximate intensity scale is linear and proportional to the number of photons collected. The "nose" seen on the left edge in (b) and (c) is an experimental artifact (shadow from the sample holder). d) Scattering simulation made assuming that the previously reported bulk structure^[22] applies to the thin film, having the crystallites oriented with the *a*-*b* plane parallel to the substrate, i.e., (001) orientation. The simulated pattern bears a strong resemblance to the experimental patterns, but upon closer inspection, it is seen that there are significant differences even in the relative positions of the low index reflections.

4. Experimental Section

Top gate, bottom contact thin film transistors with spin-coated organic semiconductor and Cytop films under nitrogen atmosphere were prepared on polyimide-coated glass substrates to help wettability. 10 nm thick gold and 5 nm thick aluminum source drain and gate electrodes, respectively, were used for the charge modulation spectroscopy experiment to reduce interference artefacts and allow semitransparency. The measurements were acquired in accumulation mode with a DC gate voltage of –35 V and an AC modulation bias of ± 5 V at 37 Hz without drain voltage (V_D = 0 V). The Cytop thickness for all samples was 500 \pm 30 nm.

Grazing incidence measurements were carried out at room temperature using the Rigaku rotating Cu-anode setup at DTU Energy, monochromatized using Xenocs multilayer mirror to wavelength $\lambda = 1.542$ Å (Cu K_a). The sample-detector distance was 120 mm, and the scattered radiation collected using Fuji imaging plates in vacuum, with exposure times of about 180 min. The intensity levels indicate the number of photon counts. The raw data images were numerically interpolated to rectilinear reciprocal space coordinates (Q_{xy}, Q_z). Simulations of the crystalline scattering were done using SimDiffraction,^[23] based on the crystallographic structure suggested by Anthony et al.^[22] Preferred 001 orientation with a distribution width of 3° (fwhm) was assumed, and the overall intensity scaling factor was fitted.

Supporting Information

Supporting Information is available from the Wiley Online Library or from the author. The data underlying this publication are available at https://www.repository.cam.ac.uk/handle/1810/252545

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